

# DESIGN AND ANALYSIS FACTORS INFLUENCING POWER SYSTEM GROUNDING

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## ABSTRACT:

In this paper a review of major AC substation grounding practices given in international standards is presented with special reference to important considerations, differences and modifications. More especially the major changes in the 2000 version of IEEE Guide for Safety in AC Substation Grounding (Standard 80-2000) with respect to the 1986 version, (Standard 80-1986) that affect the grounding design and analysis are discussed. Comparisons are made for the portions where major changes occur. Examples are presented to show the effects of the changes in the design and analysis of power system grounding.

## 1. INTRODUCTION

Grounding systems should be designed in order to prevent excessive over-voltages and voltage gradients. Fault currents may damage equipment directly or indirectly as transferred voltages may exceed allowed values in the neighborhood of the fault. Grounding systems are designed to guarantee security of personnel, protection of equipment and continuity of power supply. Hence, engineers must compute the equivalent resistance of the system and the voltage distribution on the earth surface when a fault occurs.

The main differences between the two standards are (a) the difference in mathematical equations for calculation of the reduction factor  $C_s$  for derating nominal value of surface layer resistivity, due to the installation of a surface layer of gravel. This affects the calculated max allowable or tolerable step and touch voltage values (b) the difference in the results of calculation of the developed max mesh and step voltages due to alteration on the equivalent number of parallel conductors  $n$ , the spacing factors  $K_m$  and  $K_s$  and the correction factor  $K_i$ .

In this paper the major changes in the 2000 version of IEEE Guide for Safety in AC Substation Grounding (Standard 80-2000) with respect to the

1986 version, (Standard 80-1986) that affect the grounding design and analysis are discussed.

Comparisons of the results from the two standards are made for all the portions where major changes occur. Examples are presented to show the effects of the changes on the design and analysis of power system grounding. General conclusions on the standard that leads to more economical design are drawn.

## 2. THEORETICAL BACKGROUND IN GROUNDING GRID DESIGN

### 2.1. Basic steps of the design procedure

Grounding systems design according to the IEEE standards methodology, follows particular stages, some of them iteratively:

1. Selection of material of conductors and cross section. Calculations are needed to ensure that thermal damage or erosion / corrosion will be avoided.
2. Calculation of the maximum tolerable touch and step voltages. It is based on the soil resistivity measurements, the thickness and resistivity of the surface layer of gravel and the fault duration.
3. Design of the grounding system configuration in such a way that most or all the area of the site is used. It is desirable to achieve the lowest possible grounding resistance of the grid which should be less than 1ohm.
4. Calculation of the maximum developed touch and step voltages.
5. Check if the safety criteria against harmful touch and step voltages are satisfied. If no, the grid should be reinforced by:
  - reduction of mesh dimensions
  - addition of ground rodsand maximum developed touch and step voltages must be recalculated.

The design methodology should also take into consideration the minimization of costs of materials and installation.

## 2.2. Similarities and differences between IEEE Guide for Safety in AC Grounding versions 1986 and 2000.

The two IEEE standards are similar in their structure and contents. Their differences are detected at particular mathematical equations. More analytically, in the calculation methodology and equations for:

$A_{min}$ : minimum conductor cross section area

$R_g$ : substation grounding grid resistance

$I_G$ : maximum grid current

$K$ : reflection factor

there is no difference between the two standards. However differences are observed in mathematical formulas for:

$C_s$ : the surface rating resistivity derating factor.

The two analytical equations as well as the two simplified formulas change

$n$ : the equivalent number of parallel conductors is  $\max(n_x, n_y)$  for calculation of  $K_s, K_i, E_s$

and  $\sqrt{n_x \cdot n_y}$  for calculation of  $K_m, K_i, E_m$

according to IEEE 80/1986 standard, and it is  $n_a \cdot n_b \cdot n_c \cdot n_d$  according to IEEE 80/2000 standard

Equivalent grid length for calculation of mesh voltages and step voltages if [2] is used, are given below:

$$\begin{aligned} L_m &= L_C + L_R & L_m &= L_C + 1.15L_R \\ L_s &= L_C + L_R & L_s &= L_C + 1.15L_R \end{aligned} \quad (1.a)$$

while in [3] equations (2) are proposed.

$$\begin{aligned} L_m &= L_C + L_R & L_m &= L_C + \left( 1.55 + 1.22 \frac{L_r}{\sqrt{L_x^2 + L_y^2}} \right) L_R \\ L_s &= 0.75L_C + 0.85L_R & L_s &= 0.75L_C + 0.85L_R \end{aligned} \quad (1.b) \quad (2.b)$$

Equations (1.a) and (2.a) apply to grids without ground rods or with a few ground rods scattered throughout the grid, but none located in the corners or along the perimeter of the grid. Equations (1.b) and (2.b) apply to grids with ground rods in the corners as well as along the perimeter and throughout the grid.

It can be observed that  $L_m$  at grids with rods calculated from (2.b) will always be greater than  $L_m$  from (1.b) due to the coefficient 1.55 which is larger than 1.15. This leads to a smaller  $E_m$  when the IEEE Std. 80/2000 is used. The same conclusion is not obvious for the  $L_s$  calculated according to (1.b) and (2.b) because the latter is always greater due to the coefficients 0.75 and 0.85 with comparison to 1 and 1.15. In both cases

and further investigation is needed to conclude if  $E_s$  is greater for all grids, when the 80/2000 standard is used.

General formulas of  $E_m, E_s, E_{Touch,70}$ , and  $E_{Step,70}$  are the same, but specific parameters inside the formulas have changed. These are the parameters  $n, K_i, L_m, L_s$

## 3. DIFFERENCES IN DERATING FACTOR FORMULAS

### 3.1. Surface rating resistivity derating factor

A layer of high resistivity material, such as gravel, is often spread on the earth's surface above the ground grid to increase the contact resistance between the soil and the feet of persons in the substation. The relatively shallow depth of the surface material, as compared to the equivalent radius of the foot, precludes the assumption of uniform resistivity in the vertical direction when computing the ground resistance of the feet. However for a person in the substation area, the surface material can be assumed to be of infinite extent in the lateral direction. If the underlying soil has a lower resistivity than the surface material, only some grid current will go upward into the thin layer of the surface material, the surface voltage will be very nearly the same as that without the surface material. The current through the body will be lowered considerably with the addition of the surface material because of the greater contact resistance between the earth and the feet. However this resistance may be considerably less than that of a surface layer thick enough to assume uniform resistivity in all directions. The reduction depends on the relative values of the soil and the surface material resistivities and on the thickness of the surface material.

An analytical equation for the ground resistance of the foot on a thin layer of surface material can be obtained with the use of the method of images. The analytical equation presented in the standard 80/2000 involves calculation of infinite terms. For this reason an empirical formula that gives results with an error less than 3% of the analytical results is proposed in [1]:

$$C_s = \frac{1+K}{1-K} - \frac{4 \cdot K}{p(1-K)} \tan^{-1}(2h/b) - 0.21K^2(e^{-7h} - e^{-30h}) \quad (3)$$

The empirical formula (4) is proposed in the standard 80/2000 and is much simpler than (3).

$$C_s(\mathbf{r})_{80/2000} = 1 - \frac{0.09 \cdot \left(1 - \frac{\mathbf{r}}{\mathbf{r}_s}\right)}{2 \cdot h_s + 0.09} \quad (4)$$

where

- $\rho$ : soil resistivity
- $\rho_s$ : surface layer resistivity

The analytical mathematical equation proposed in standard 80/1986 is as follows:

$$C_s = \left[ 1 + 2 \cdot \sum_n \frac{K^n}{\sqrt{1 + \left(\frac{2 \cdot n \cdot h_s}{0.08}\right)^2}} \right] \cdot 0.96^{-1} \quad (5)$$

while the empirical formula proposed in standard 80/1986 is:

$$C_s(\mathbf{r})_{80/1986} = 1 - \frac{0.106 \cdot \left(1 - \frac{\mathbf{r}}{\mathbf{r}_s}\right)}{2 \cdot h_s + 0.106} \quad (6)$$

In the following, the values of coefficient  $C_s$  calculated according to (3) to (6) are compared, considering surface layer of gravel of thickness  $h_s$  equal to 0.05m, 0.10m, 0.15m, 0.20m, 0.25m, 0.30m. Soil resistivity  $\rho$  varies, being always less than the special resistivity of gravel  $\rho_s$ .

To estimate the percentage of difference between the values obtained from standard 80/1986 and standard 80/2000, function (7) is evaluated and plotted in figs 1 and 2.

$$F_{C_s}(\mathbf{r}) = \frac{C_s(\mathbf{r})_{80/2000} - C_s(\mathbf{r})_{80/1986}}{C_s(\mathbf{r})_{80/1986}} \cdot 100\% \quad (7)$$

The surface layer of gravel is considered to have special resistivity  $\rho_s$  equal to 1000 Ohm, 2500 Ohm and 3000 Ohm and thickness  $h_s$  equal to 0.05m, 0.10m, 0.15m, 0.20m, 0.25m, 0.30m. Fig. 1 demonstrates the comparison of the results of (3) and (5) while fig.2 demonstrates the comparison of the results of (4) and (6).

From diagrams of fig.1 where the results of the analytical formula (3) and the empirical formula (5) have been used, the following are deduced:

- Values for  $C_s$  as calculated from standard 80/1986 and standard 80/2000 are equal for a particular value of soil resistivity  $\rho_?$  which depends on the characteristics of the surface layer  $h_s$  and  $\rho_s$
- When soil resistivity is higher than  $\rho_?$  the value from standard 80/2000 becomes smaller than the value from standard 80/1986.

- For particular thickness of layer of gravel  $h_s$ , the  $\rho_?$  takes higher values if the soil resistivity of the surface layer of gravel takes also higher value.

It should be noted however, that in all of the cases where it is practically feasible to install a substation grounding grid, soil resistivity does not exceed 400 Ohms, therefore the value of  $C_s$  calculated from the new standard will be always higher than the corresponding  $C_s$  calculated using the old standard.

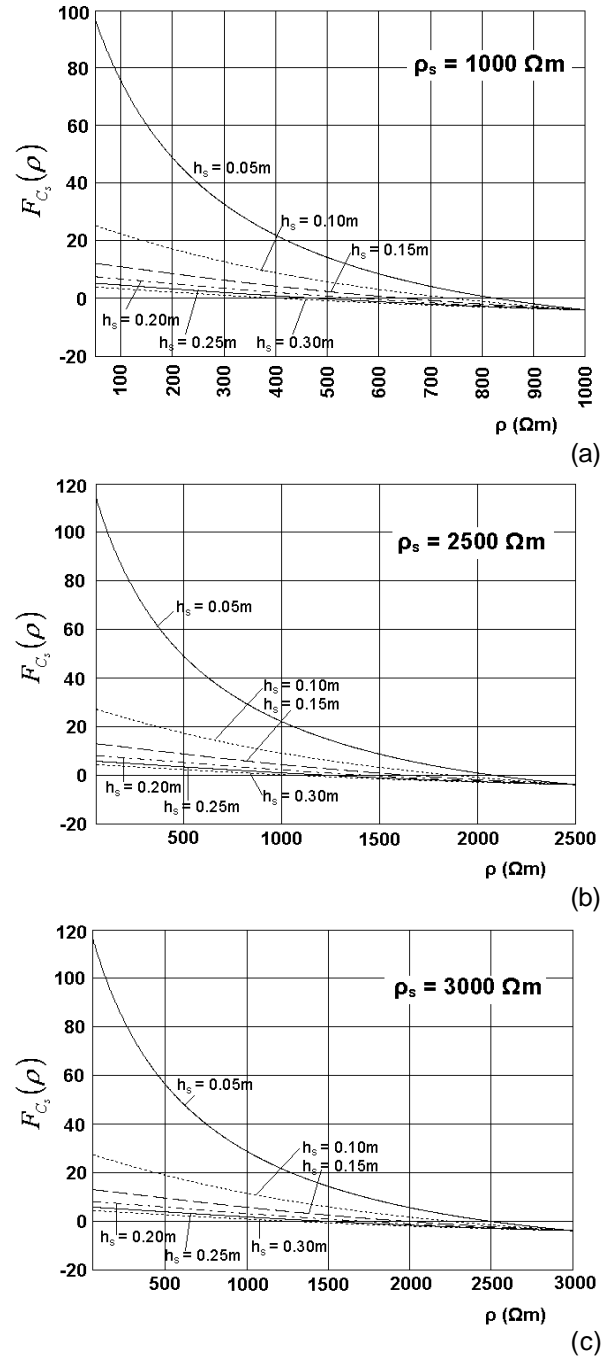
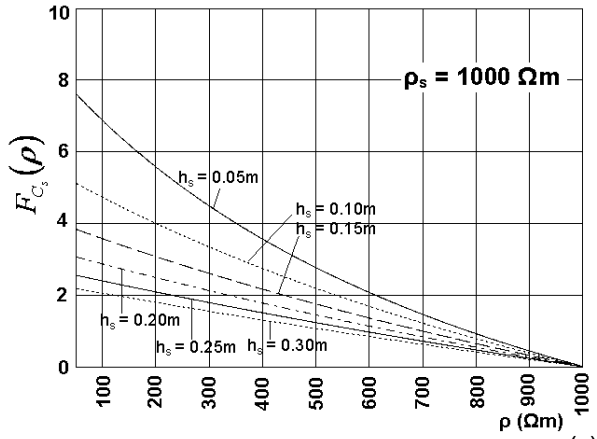
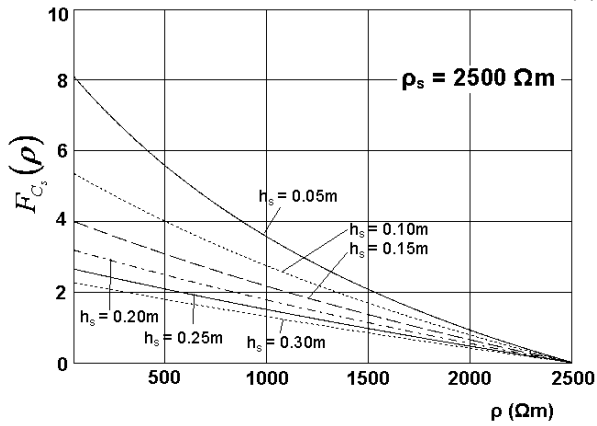


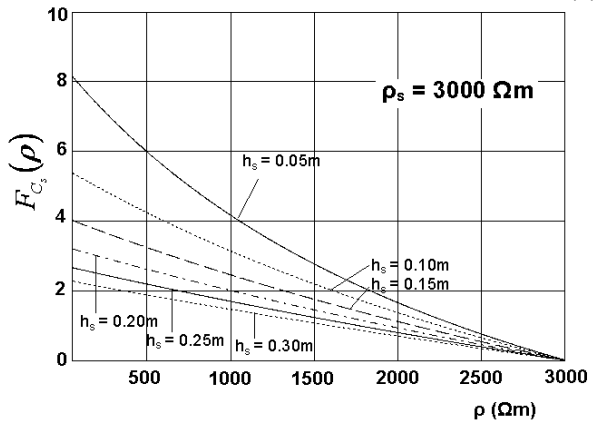
Figure 1: Curve of  $F_{C_s}(\mathbf{r})$  with respect to  $\rho$ , (a)  $\rho_s = 1000 \text{ Ohm}$ , (b)  $\rho_s = 2500 \text{ Ohm}$ , (c)  $\rho_s = 3000 \text{ Ohm}$



(a)



(b)



(c)

Figure 2: Curve of  $F_{C_s}(\mathbf{r})$  with respect to  $\rho$ , (a)  $\rho_s = 1000 \text{ Om}$ , (b)  $\rho_s = 2500 \text{ Om}$ , (c)  $\rho_s = 3000 \text{ Om}$

From diagrams of fig.2 where the results of the empirical formulae (4) and (6) have been compared, the following are deduced:

- The empirical formula proposed in 80/1986 for calculation of  $C_s$  results in higher values in all cases than the empirical formula proposed in 80/2000
- In all cases the values resulting from the new standard 80/2000 are higher.

#### 4. INFLUENCE OF DERATING FACTOR IN TOLERABLE TOUCH VOLTAGES

Maximum tolerable touch voltages are in both the IEEE standards given by the following equation:

$$E_{touch,70} = (1000 + 1.5 \cdot C_s \cdot r_s) \frac{0.157}{\sqrt{t_s}} \quad (8)$$

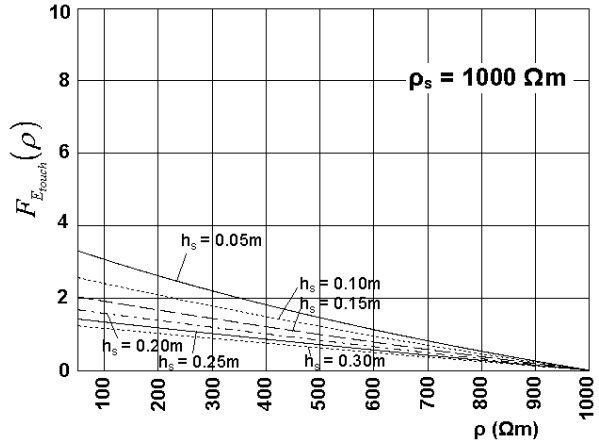
Maximum tolerable touch voltage for 50 kg human body  $E_{touch,50}$ , can be also calculated from (8) where the coefficient 0.116 is used instead of 0.157.

Values of  $E_{touch,70}$  calculated from [2] and [3] are compared, considering surface layer of gravel of thickness  $h_s$  equal to 0.05m, 0.10m, 0.15m, 0.20m, 0.25m, 0.30m. Soil resistivity varies, being always less than the special resistivity of gravel and surface derating factor  $C_s$  is calculated from (4) and (6). To estimate the percentage of difference between the values obtained from Std.80/1986 and Std.80/2000, function (9) is evaluated and plotted as shown in fig 3 using empirical formulae for  $C_s$ .

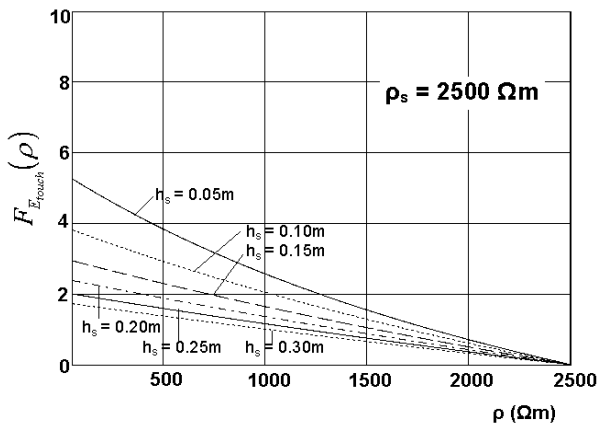
$$\begin{aligned} F_{E_{touch,50}}(\mathbf{r}) &= F_{E_{touch,70}}(\mathbf{r}) = \\ &= \frac{E_{touch,70}(\mathbf{r})_{80/2000} - E_{touch,70}(\mathbf{r})_{80/1986}}{E_{touch,70}(\mathbf{r})_{80/1986}} \cdot 100\% \\ &= \frac{1.5 \cdot r_s \cdot (C_s(\mathbf{r})_{80/2000} - C_s(\mathbf{r})_{80/1986})}{1000 + 1.5 \cdot r_s \cdot C_s(\mathbf{r})_{80/1986}} \cdot 100\% \end{aligned} \quad (9)$$

In diagrams of fig. 3, the following can be observed:

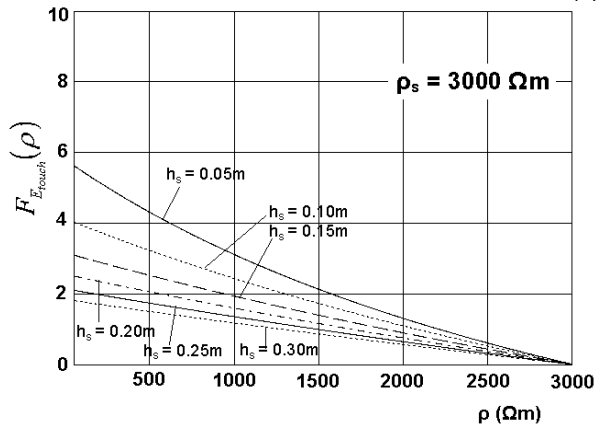
- Application of the new standard [3] leads always in higher values of tolerable touch voltages than the old standard [2]
- $F_{E_{touch}}$  varies almost linearly with soil resistivity.
- Larger differences in  $E_{touch}$  calculated from the two standards, appear when resistivity of the surface layer of gravel is the highest possible (3000Om).
- Larger differences in  $E_{touch}$  from the two standards when the surface layer resistivity remains the same are also observed when the thickness of the surface layer is smaller.
- Percentages of difference between the values obtained from the two standards do not depend on the time duration of the fault or the weight of the human body.



(a)



(b)



(c)

Figure 3: Curve of  $F_{E_{touch}}(\mathbf{r})$  with respect to  $\rho$ , (a)  $\rho_s = 1000 \text{ Om}$ , (b)  $\rho_s = 2500 \text{ Om}$ , (c)  $\rho_s = 3000 \text{ Om}$

## 5. INFLUENCE OF DERATING FACTOR IN TOLERABLE STEP VOLTAGES

Maximum tolerable step voltages are in both the IEEE standards [2] and [3] given by equation (10):

$$E_{step,70} = (1000 + 6 \cdot C_s \cdot r_s) \frac{0.157}{\sqrt{t_s}} \quad (10)$$

As previously, the maximum tolerable step voltage for 50 kg human body  $E_{step,50}$ , can be also calculated from (10) where the coefficient 0.116 instead of 0.157 should be used.

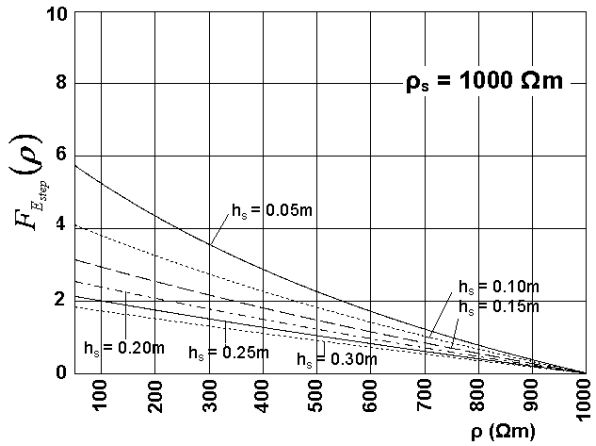
The values of  $E_{step,70}$  calculated from the empirical formulae suggested in [2] and [3] are compared, considering surface layer of gravel of thickness  $h_s$  equal to 0.05m, 0.10m, 0.15m, 0.20m, 0.25m, 0.30m. Soil resistivity varies, being always less than the special resistivity of gravel and surface derating factor  $C_s$  is calculated from (4) and (6).

To estimate the percentage of difference between the values obtained from standard 80/1986 and standard 80/2000, function (11) is evaluated and plotted as shown in fig 4.

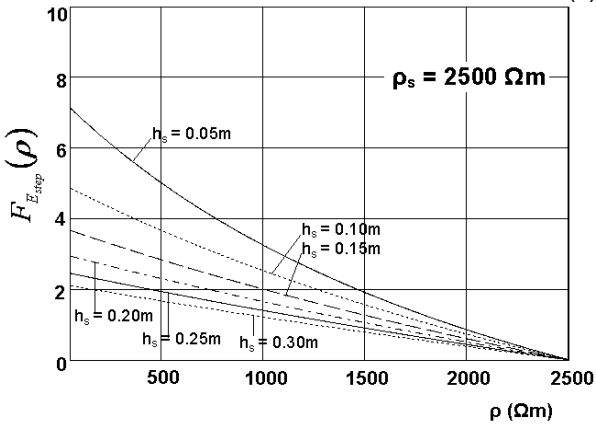
$$\begin{aligned} F_{E_{step,50}}(\mathbf{r}) &= F_{E_{step,70}}(\mathbf{r}) = \\ &= \frac{E_{step,70}(\mathbf{r})_{80/2000} - E_{step,70}(\mathbf{r})_{80/1986}}{E_{step,70}(\mathbf{r})_{80/1986}} \cdot 100\% \\ &= \frac{6 \cdot r_s \cdot (C_s(\mathbf{r})_{80/2000} - C_s(\mathbf{r})_{80/1986})}{1000 + 6 \cdot r_s \cdot C_s(\mathbf{r})_{80/1986}} \cdot 100\% \end{aligned} \quad (11)$$

In diagrams of fig. 4, the following can be observed:

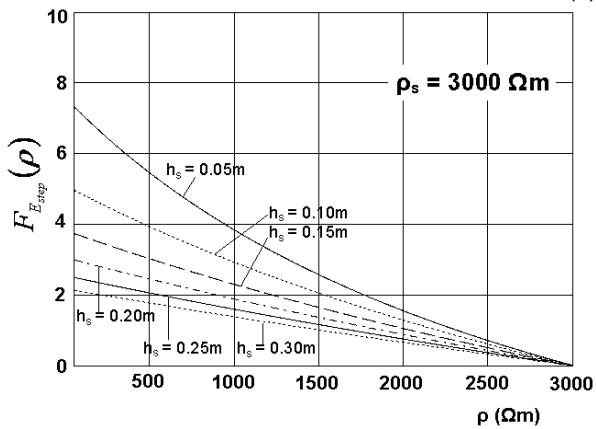
- Application of the new standard [3] always results in higher values of tolerable step voltages than application of the old standard [2]
- $F_{E_{step}}$  varies almost linearly with soil resistivity.
- Larger differences in  $E_{step}$  calculated from the two standards, appear when special resistivity of the surface layer of gravel is the highest possible (3000Om).
- Larger differences in  $E_{step}$  calculated from the two standards for the same surface layer resistivity, appear when the thickness of the surface layer is smaller.
- Percentages of difference between the values calculated from the two standards do not depend on the duration of the fault or the human weight.



(a)



(b)



(c)

Figure 4: Curve of  $F_{E_{step}}(\rho)$  with respect to  $\rho$ , (a)  $\rho_s = 1000 \Omega m$ , (b)  $\rho_s = 2500 \Omega m$ , (c)  $\rho_s = 3000 \Omega m$

## 6. DIFFERENCES IN THE DEVELOPED TOUCH AND STEP VOLTAGES

In this paragraph, values of the maximum developed at the surface of the substation grounding grid, calculated from the two IEEE standards [2] and [3] are compared. Equations for touch and step voltages are given below:

$$E_m = r \cdot K_i \cdot K_m \cdot I_G / L_M \quad (12)$$

$$E_s = r \cdot K_i \cdot K_s \cdot I_G / L_S$$

It should be noted that maximum developed touch and step voltages vary linearly with respect to soil resistivity and they are calculated from the same mathematical equations in both the standards, thus most of the conclusions drawn for a specific value of soil resistivity, apply for any soil resistivity.

In the following only orthogonal and square grounding grids are considered. For these grid configurations the differences between the calculated developed voltages using the two standards are larger than when the L shape or any shape grids are considered.

For the parameters of the grid, that don't change throughout calculations, typical values are chosen i.e. diameter of the conductors of the grid is 0.01m, grid depth is 0.60m, and current to ground  $I_G$  is 15kA. Soil resistivity is 1000 $\Omega m$ . In general, realistic grounding grids configurations are calculated. Resulting voltages are contrasted to the maximum tolerable values when the duration of fault is taken equal to 0.5s, and the surface layer of gravel is of 0.10m thickness and 2500 $\Omega m$  resistivity. Results of calculations are presented in details in App.1.

### 6.1. Maximum developed touch voltage

**6.1.1. Grids with no ground rods or with only a few ground rods scattered throughout the grid, but none in the corners or along the perimeter of the grid.** Differences between the values of the standard 80/1986 and the 80/2000 are due to the differences in:

- the equivalent number of parallel conductors  $n$  which is calculated from different mathematical equation as it is described in 2.2.
- the correction factor  $K_i$  which is also calculated using different mathematical equations, introducing a difference in the results even when  $n$  from the two standards is the same as in the square grounding grids.

In fig 5 the ratio of  $E_m$  calculated according to the 80/2000 standard to the value calculated according to the 80/1986 standard is plotted considering that mesh dimension varies between 2.5m and 10m. In calculation results the following can be observed:

- The ratio of  $E_m$  calculated according to the 80/2000 standard to the value calculated according to the 80/1986 standard increases linearly and almost with the same slope if mesh dimensions increase, in all the examined cases.

- $Em_{80/2000} / Em_{80/1986}$  ratio when the grid has a few rods in the center, and the exactly the same configuration in the two cases, is equal to the ratio of  $Em_{80/2000} / Em_{80/1986}$  calculated for the case when there are no rods at all.
- For the same grid sides ratio,  $Em$  value calculated with the 80/2000 standard is a lower percentage of  $Em$  calculated with the 80/1986 standard if the area of the grid increases
- Keeping the same grid area and redesigning the grid with a larger sides ratio, results in values of  $Em$  from the new standard closer to those of the old standard, and higher  $Em_{80/2000} / Em_{80/1986}$ .

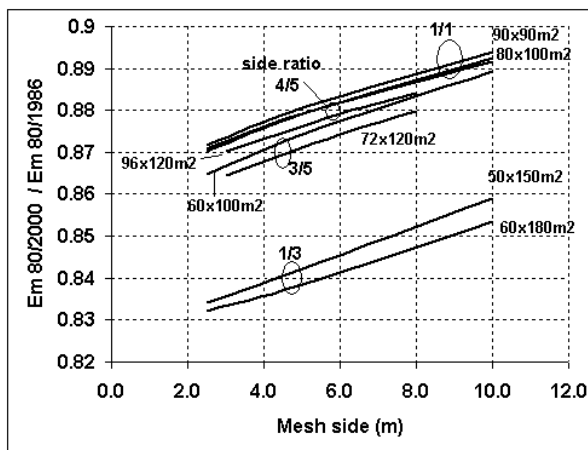


Figure 5: Ratio of  $Em_{80/2000} / Em_{80/1986}$  versus mesh side dimension for grids without rods

It is also generally observed in the results that in all cases the  $Em$  values from the 80/1986 as well as from the 80/2000 standard depend exponentially on the total length of conductors  $L_M$  raised in a power  $0.70 \pm 10^{-2}$

**6.1.2. Grids with ground rods in the corners as well as in the perimeter and throughout the grid.** Differences between the values of the first and the second standard are due to the differences in:

- The equivalent number of parallel conductors  $n$  which is different as explained in 6.1.1.
- Total length  $L_m$  of grounding conductors which is different for the same reason as referred in the previous paragraph 6.1.1.
- The correction factor  $K_i$  which is calculated using different mathematical equations, introducing a difference in the results even when  $n$  from the two standards is the same as in the square grounding grids.

In fig 6 the ratio of  $Em$  calculated according to the 80/2000 standard to the value calculated according to the 80/1986 standard is plotted

considering that mesh dimension varies between 2.5m and 10m. Additionally 100m rods are installed along the perimeter and throughout the area of the grid. In calculation results the following can be observed:

- As for grids without rods the ratio of  $Em$  calculated according to the 80/2000 standard to the value calculated according to the 80/1986 standard increases linearly and almost with the same slope if mesh dimensions increase, in all the examined cases.
- $Em_{80/2000} / Em_{80/1986}$  compared to the values of the same ratio in fig.5 are lower when all the other design parameters are the same.
- If more 100m rods are added to the grid,  $Em_{80/2000} / Em_{80/1986}$  ratio remains almost constant versus mesh dimension and for grid sides ratio 1/3, 3/5, 4/5 and 1/1 it is approximately equal to 0.823, 0.850, 0.860, 0.860. Consequently it lower than the ratio plotted in fig. 6.
- The same observations made for the results shown in fig.5 apply in this case.

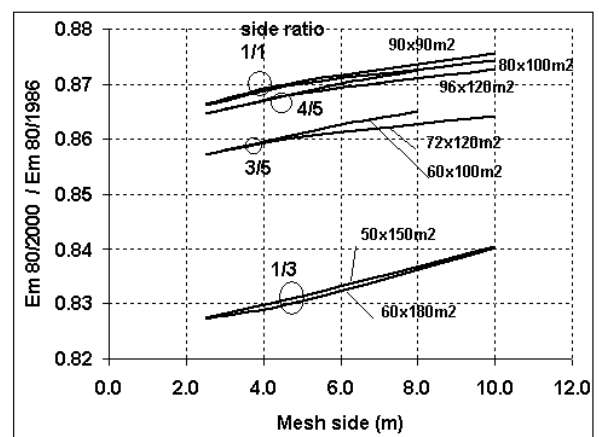


Figure 6: Ratio of  $Em_{80/2000} / Em_{80/1986}$  versus mesh side dimension for grids with rods

As in the previous case it is also generally observed in the results that in all cases the  $Em$  values from both versions of standards depend exponentially on the total length of conductors  $L_M$  raised in a power of 0.69 to 0.74

## 6.2. Maximum developed step voltage

**6.2.1. Grids with no ground rods or with only a few ground rods scattered throughout the grid, but none in the corners or along the perimeter of the grid.** Differences between the values of the first and the second standard are due to the differences explained in the previous paragraphs considering:

- the equivalent number of parallel conductors  $n$
- Total length of grounding conductors  $L_s$

- Correction factor  $K_f$ .

In the results of table A.1 it is observed that the maximum developed step voltage calculated according to std. 80/2000 is lower than the step voltage calculated according to std 80/1986 only when the ratio of sides is 1/3. However the safety criteria are satisfied in all examined cases

**6.2.2. Grids with ground rods in the corners as well as in the perimeter and throughout the grid.** Differences between the values of the first and the second standard are due to the differences explained in the previous paragraphs considering:

- the equivalent number of parallel conductors  $n$
- Total length of grounding conductors  $L_s$
- Correction factor  $K_f$ .

In the results of table A.2 it is observed that the maximum developed step voltage calculated according to std. 80/2000 is lower than the step voltage calculated according to standard 80/1986 only when the ratio of sides is 1/3. This is the same as if the rods were placed at the center of the grid. The safety criteria are satisfied in all examined cases.

## 7. CONSIDERATIONS ON SAFETY MARGINS

For the same area of the grid and the same grid and mesh dimensions the calculated mesh voltage  $E_m$  with the new standard is equal to a percentage of the old one and the tolerable touch voltage  $E_{\text{touch},70}$  from the 80/1986 standard is 99% or smaller than  $E_{\text{touch},70}$  from the 80/2000 standard as it can be shown in fig.3. Thus the safety margin given by the new standard for the existing grounding arrangements is greater. If a model for linear dependence of  $E_m$  on  $L_M^{-0.6 \text{ to } -0.8}$  is adopted it will be possible to calculate the saving on conductor length needed to achieve the same safety criteria if the 80/2000 standard is used instead of 80/1986 standard.

## 7. CONCLUSIONS

In this paper a review of major AC substation grounding practices given in the IEEE international standards is presented with special

reference to important considerations, differences and modifications. Comparisons are made for the portions where major changes occur. Examples are presented to show the effects of the changes on the design and analysis of power system grounding.

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## Appendix I.

Results from calculations of square and orthogonal grids with sides ratio 1/3 to 4/5 where there are no ground rods or there are a few ground rods scattered throughout the grid, but none located in the corners or along the perimeter of the grid are shown in Table A.1.

Results from calculations of square and orthogonal grids with sides ratio 1/3 to 4/5 where there exist ground rods in the corners as well as along the perimeter and throughout the grid are shown in Table A.2.

For the parameters of the grids, that don't change throughout calculations, and are not shown in Tables A.1 and A.2 typical values are chosen i.e. diameter of the conductors of the grid is 0.01m, grid depth is 0.60m, and current to ground  $I_g$  is 15kA. Soil resistivity is 100Om. The duration of fault is taken equal to 0.5s, and the surface layer of gravel is of 0.10m thickness and 2500Om resistivity.



Table A.1: Results of calculations for grids without rods

Grid Dimensions	Mesh	Length of horizontal conductors (m)	Total length of ground rods (m)	Em Calculation Parameters (80/2000)						Em Calculation Parameters (80/1986)						Es Calculation Parameters (80/2000)			Es Calculation Parameters (80/1986)			ANSI IEEE Std. 80-2000			ANSI IEEE Std. 80-1986				
				n	K <sub>1</sub>	K <sub>2</sub>	L <sub>1</sub>	K <sub>3</sub>	E <sub>0</sub> (V)	n	K <sub>1</sub>	K <sub>2</sub>	L <sub>1</sub>	K <sub>3</sub>	E <sub>0</sub> (V)	L <sub>1</sub>	K <sub>2</sub>	E <sub>0</sub> (V)	L <sub>1</sub>	K <sub>2</sub>	n	K	E <sub>0</sub> (V)	C <sub>i</sub>	E Step,70	E Touch,70	C <sub>i</sub>	E Step,70	E Touch,70
50x150m <sup>2</sup>	10x10m	1700	0	9.134	1.996	0.629	1700	0.977	1719.6	9.798	2.341	0.645	1700	0.968	1950	1.275	0.327	267.5	1.700	0.527	16	3.408	863.7						
	5x5m	3300	0	17.193	3.189	0.663	3300	0.962	3693.9	18.466	3.832	0.676	3300	0.652	1170.4	2.400	0.396	766.8	3.300	0.396	31	5.988	1062.8						
	2.5x2.5m	6300	0	33.312	5.574	0.717	6300	0.309	616.5	35.791	6.812	0.788	6300	0.307	880.4	4.600	0.495	680.5	6.300	0.495	61	11.148	1536.5	0.702	2560.0	806.5	0.667	2443.5	777.4
	10x10m	1700	100	9.134	1.996	0.629	1800	0.977	1624.1	9.798	2.341	0.645	1800	0.968	1688.0	1.360	0.327	219.6	1.800	0.527	16	3.408	863.7						
	5x5m	3300	100	17.193	3.189	0.663	3300	0.962	3693.9	18.466	3.832	0.676	3300	0.652	1136.0	2.495	0.396	742.5	3.300	0.396	31	5.988	1060.0						
	2.5x2.5m	6300	100	33.312	5.574	0.717	6300	0.309	603.8	35.791	6.812	0.788	6300	0.307	862.2	4.735	0.495	674.5	6.300	0.495	61	11.148	1514.6						

Table A.2: Results of calculations for grids with rods

Grid Dimensions	Mesh	Length of horizontal conductors (m)	Total length of ground rods (m)	Em Calculation Parameters (80/2000)						Em Calculation Parameters (80/1986)						Es Calculation Parameters (80/2000)			Es Calculation Parameters (80/1986)			ANSI IEEE Std. 80-2000			ANSI IEEE Std. 80-1986				
				n	K <sub>1</sub>	K <sub>2</sub>	L <sub>1</sub>	K <sub>3</sub>	E <sub>0</sub> (V)	n	K <sub>1</sub>	K <sub>2</sub>	L <sub>1</sub>	K <sub>3</sub>	E <sub>0</sub> (V)	L <sub>1</sub>	K <sub>2</sub>	E <sub>0</sub> (V)	L <sub>1</sub>	K <sub>2</sub>	n	K	E <sub>0</sub> (V)	C <sub>i</sub>	E Step,70	E Touch,70	C <sub>i</sub>	E Step,70	E Touch,70
50x150m <sup>2</sup>	10x10m	1700	0	9.134	1.996	0.629	1700	0.977	1719.6	9.798	2.341	0.645	1700	0.968	1950	1.275	0.327	267.5	1.700	0.527	16	3.408	863.7						
	5x5m	3300	0	17.193	3.189	0.663	3300	0.962	3693.9	18.466	3.832	0.676	3300	0.652	1170.4	2.400	0.396	766.8	3.300	0.396	31	5.988	1062.8						
	2.5x2.5m	6300	0	33.312	5.574	0.717	6300	0.309	616.5	35.791	6.812	0.788	6300	0.307	880.4	4.600	0.495	680.5	6.300	0.495	61	11.148	1536.5	0.702	2560.0	806.5	0.667	2443.5	777.4
	10x10m	1700	200	9.134	1.996	0.629	1800	0.977	1624.1	9.798	2.341	0.645	1800	0.968	1688.0	1.360	0.327	219.6	1.800	0.527	16	3.408	863.7						
	5x5m	3300	200	17.193	3.189	0.663	3300	0.962	3693.9	18.466	3.832	0.676	3300	0.652	1136.0	2.495	0.396	742.5	3.300	0.396	31	5.988	1060.0						
	2.5x2.5m	6300	200	33.312	5.574	0.717	6300	0.309	603.8	35.791	6.812	0.788	6300	0.307	862.2	4.735	0.495	674.5	6.300	0.495	61	11.148	1514.6						